

Enhancement Mode N-Channel Power MOSFET

 $TO-252/NMOS/70V/\pm20V/3.0V/51A/6.1m\Omega$

Rev0.1





70V, 6.1mΩ, 51A, N-Channel Enhancement MOSFET

1.Features

- ♦ 70V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±20V
- ◆ 100% RG Tested
- ◆ 100% UIS Tested

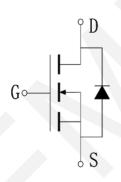
2.Applications

- Power Switching Application
- ◆ Load Switching



TO-252 Pin Description

| V_{DS} | R _{DS(on)} Typ. | I _D Max. |
|-----------------|--------------------------|---------------------|
| 70V | 6.1mΩ @ 10V | 51A |



Schematic Diagram

3. Package Marking and Ordering Information

| Part no. | Marking | Package | PCS/Reel | PCS/CTN. |
|----------|---------|---------|----------|----------|
| WP6888 | 6888 | TO-252 | 2,500 | 25,000 |

4.Absolute Max Ratings at Ta=25°C (Note1)

| Parameter | Symbol | Maximum | Units |
|---------------------------------|-----------------|-------------|-------|
| Drain to Source Voltage | V_{DSS} | 70 | V |
| Gate to Source Voltage | V_{GSS} | ±20 | V |
| Drain Current (DC) | I_D | 51 | А |
| Drain Current (Pulse), PW≤300μs | I _{DP} | 204 | А |
| Total Dissipation | P_{D} | 46.3 | W |
| Avalanche Energy, Single Pulsed | E _{AS} | 206 | mJ |
| Junction Temperature | T_j | 150 | °C |
| Storage Temperature | T_{stg} | -55 to +150 | °C |

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings

| Parameter | Symbol | Value | Unit |
|------------------|------------------|-------|------|
| Junction to Case | R _{eJC} | 2.7 | °C/W |

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

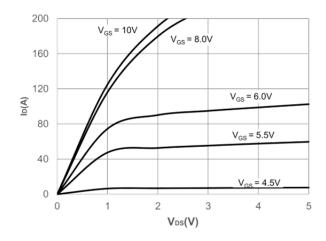
6.Electrical Characteristics at Ta=25°C (Note 3)

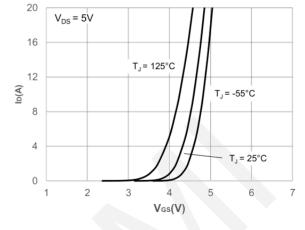
| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Units |
|--|----------------------|--|------|------|------|-------|
| Drain to Source Breakdown Voltage | V _{(BR)DSS} | $I_D = 250 \mu A, V_{GS} = 0 V$ | 70 | - | - | V |
| Zero-Gate Voltage Drain Current | I _{DSS} | V_{DS} =70V, V_{GS} = 0V | - | 1 | 1 | μΑ |
| Gate to Source Leakage Current | I _{GSS} | $V_{GS} = \pm 20V$, $V_{DS} = 0V$ | ı | - | ±100 | nA |
| Gate Threshold Voltage | $V_{GS(th)}$ | V _{DS} =V _{GS} , I _{DS} =250μA | 2.0 | 3.0 | 4.0 | ٧ |
| Static Drain to Source On-State Resistance | R _{DS(on)} | I _D =30A, V _{GS} = 10V | | 6.1 | 7.9 | mΩ |
| Input Capacitance | C_{iss} | V _{GS} =0V, | - | 5463 | - | pF |
| Output Capacitance | C _{oss} | V _{DS} =35V, Frequency=1.0MHz | - | 250 | - | pF |
| Reverse Transfer Capacitance | C _{rss} | | - | 199 | - | pF |
| Turn-ON Delay Time | t _{d(on)} | $V_{DS} = 35V, V_{GS} = 10V,$ $I_{D} = 30A, R_{GEN} = 3\Omega$ | - | 20 | - | ns |
| Rise Time | t _r | | - | 30 | - | ns |
| Turn-OFF Delay Time | t _{d(off)} | | - | 45 | - | ns |
| Fall Time | t _f | | - | 14 | - | ns |
| | Q_g | $V_{DS} = 35V,$ $V_{GS} = 0 \text{ to } 10V,$ $I_{D} = 30A$ | - | 94 | - | nC |
| Total Gate Charge | Q_{gs} | | - | 30 | - | nC |
| | Q_{gd} | | - | 24 | - | nC |
| Diode Forward Voltage | V_{FSD} | I _S =30A, V _{GS} = 0 | - | - | 1.2 | V |

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



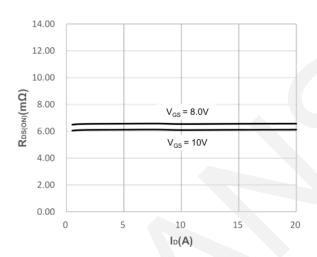
7. Typical electrical and thermal characteristics

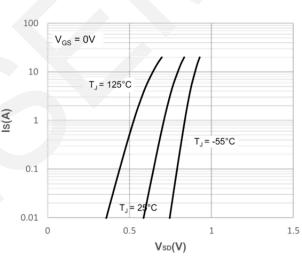




Output Characteristics

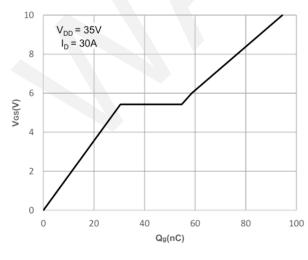
Typical Transfer Characteristics

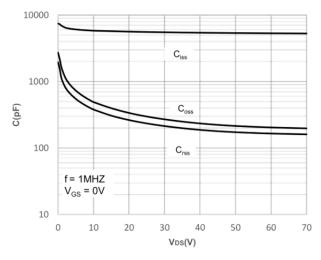




On-resistance vs. Drain Current

Body Diode Characteristics

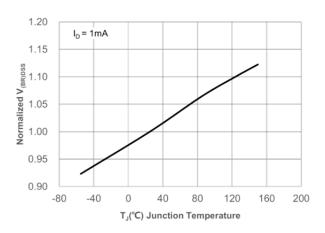




Gate Charge Characteristics

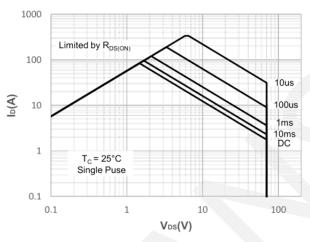
Capacitance Characteristics



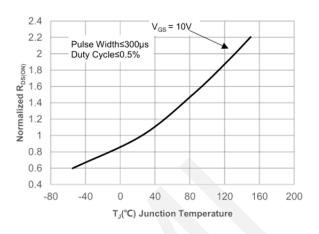


Normalized Breakdown Voltage vs.

Junction Temperature

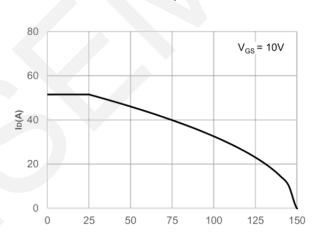


Maximum Safe Operating Area



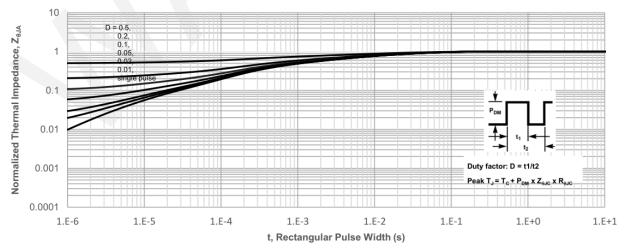
Normalized on Resistance vs.

Junction Temperature



Maximum Continuous Drain Current vs.

Case Temperature

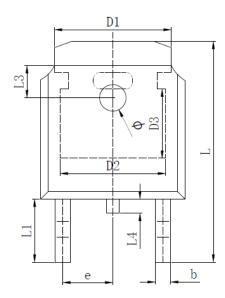


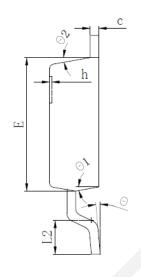
Maximum Effective Transient

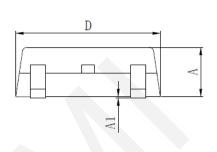
Thermal Impedance, Junction-to-Case



8.Package Dimensions







| SYMBOL | MILLIMETER | | | |
|--------|------------|-----------|---------|--|
| | MIN | Тур. | MAX | |
| A | 2. 200 | 2.300 | 2. 400 | |
| A1 | 0.000 | | 0. 127 | |
| b | 0.640 | 0.690 | 0.740 | |
| c(电镀后) | 0. 460 | 0.520 | 0. 580 | |
| D | 6. 500 | 6. 600 | 6. 700 | |
| D1 | | 5.334 REF | | |
| D2 | 4.826 REF | | | |
| D3 | 3.166 REF | | | |
| Е | 6. 000 | 6. 100 | 6. 200 | |
| е | 2.286 TYP | | | |
| h | 0.000 | 0.100 | 0. 200 | |
| L | 9. 900 | 10. 100 | 10. 300 | |
| L1 | 2.888 REF | | | |
| L2 | 1. 400 | 1.550 | 1. 700 | |
| L3 | 1.600 REF | | | |
| L4 | 0.600 | 0.800 | 1. 000 | |
| ф | 1. 100 | 1. 200 | 1. 300 | |
| θ | 0° | | 8° | |
| θ 1 | 9° TYP | | | |
| θ2 | 9° TYP | | | |



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